

**Search Notes**

Application/Control No.

10/573,460

Examiner

Tan T. Nguyen

Applicant(s)/Patent under  
Reexamination

SATO, TOMOTOSHI

Art Unit

2827

**SEARCHED**

Class	Subclass	Date	Examiner
365	195	4/25/2007	TNT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
365	200	4/25/2007	TNT
365	185.09	4/25/2007	TNT
365	189.07	4/25/2007	TNT
365/195, 201		4/25/2007	TNT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
365/185.09, 189.07, 200, 201 (text search only - see search history printout)	4/25/2007	TNT
PGPUB text search (see interference search printout)	4/25/2007	TNT